## Application/Control No. Applicant(s)/Patent Under Reexamination 08/964,257 TERASHIMA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2625 Madeleine AV Nguyen **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-5,153,736 10-1992 Stemmle, Denis J. 358/296 Α \* US-5,579,129 11-1996 Iwata et al. 358/474 В US-С US-D US-Ε US-F US-G US-Н US-US-US-K US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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